Applicant(s)/Patent Under Application/Control No. Reexamination 09/626,347 DE HEER ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Alford W. Kindred 2163 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-7,107,226 09-2006 Cassidy et al. 705/26 Α В US-US-С US-D US-Ε US-F US-G US-Н US-1 US-J US-K US-L US-М **FOREIGN PATENT DOCUMENTS** Date **Document Number** Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

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